

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L4	340	threshold\$4 near4 (window or box or area or zone or region or range or limit or tolerance) with defect and wafer	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 09:18
L5	202	threshold\$4 near4 (window or box or area or zone or region or range or limit or tolerance) with defect and wafer and pixel	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 09:21
L6	220	threshold\$4 near4 (window or box or area or zone or region or range or limit or tolerance or mask) with defect and wafer and pixel	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 09:25
L7	505	threshold\$4 near4 (window or box or area or zone or region or range or limit or tolerance or mask) with defect and pixel	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 09:37
L8	467	threshold\$4 near4 (window or box or area or zone or region or range or limit or tolerance or mask) with defect \$4 and pixel with defect\$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 09:37

L9	143	threshold\$4 near4 (window or box or area or zone or region or range or limit or tolerance or mask) with defect \$4 with (between or within or inside or interior) and pixel with defect \$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 09:39
L10	189	threshold\$4 near4 (window or box or area or zone or region or range or limit or tolerance or mask) with defect \$4 with (between or within or inside or interior or inner or in) and pixel with defect \$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 09:40
L11	19	threshold\$4 near4 (upper with lower) with defect\$4 with (between or within or inside or interior or inner or in) and pixel with defect\$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 09:58
L12	64	threshold\$4 near4 (upper with lower) with defect\$4 with (between or within or inside or interior or inner or in)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 10:03
L13	27	threshold\$4 near4 (upper with lower) with defect\$4 with (between or within or inside or interior or inner or in) and pixel	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 10:03

L14	69	threshold\$4 near4 (upper with lower) with defect\$4 and pixel	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 10:04
L15	0	(threshold\$4 near4 (upper with lower) with defect\$4 and pixel).clm.	US-PGPUB	OR	ON	2008/08/18 10:12
L16	164	(threshold\$4 with defect\$4 and pixel).clm.	US-PGPUB	OR	ON	2008/08/18 10:12
L17	76	(threshold\$4 with defect\$4 and pixel and (difference or subtract\$4)).clm.	US-PGPUB	OR	ON	2008/08/18 10:13
L18	51	(threshold\$4 with defect\$4 with (region or zone or area or range) and pixel).clm.	US-PGPUB	OR	ON	2008/08/18 10:13
L19	15	(kim with deok- yong).in.	US-PGPUB; USPAT	OR	ON	2008/08/18 10:44
L20	17	((kim with deok- yong) or (lee with byoung-ho)).in.	US-PGPUB; USPAT	OR	ON	2008/08/18 10:45
L21	10	((kim with deok- yong) or (lee with byoung-ho)).in. and defect	US-PGPUB; USPAT	OR	ON	2008/08/18 10:45
L22	6	((kim with deok- yong) or (lee with byoung-ho)).in. and defect and threshold\$4	US-PGPUB; USPAT	OR	ON	2008/08/18 10:45
L23	7	((kim with deok- yong) or (lee with byoung-ho)).in. and defect\$4 and threshold\$4	US-PGPUB; USPAT	OR	ON	2008/08/18 10:45
L24	1	"6545491".pn.	US-PGPUB; USPAT	OR	ON	2008/08/18 10:51
L25	1	"6100102".pn.	US-PGPUB; USPAT	OR	ON	2008/08/18 10:52

L26	1	"6995074".pn.	US-PGPUB; USPAT	OR	ON	2008/08/18 10:52
L27	1	"7245365".pn.	US-PGPUB; USPAT	OR	ON	2008/08/18 10:54
L28	73	defect with noise with threshold\$4 with (region or zone or area)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 10:59
L29	79	(defect or flaw) with noise with threshold\$4 with (region or zone or area)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 11:00
L30	600	(defect or flaw) with threshold\$4 with (within)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 11:14
L31	259	(defect or flaw) with threshold\$4 with (within) and pixel	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 11:15
L32	15	(defect or flaw) with threshold\$4 near2 (range or tolerance) with (within) and pixel	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/18 11:16
S30	28961	threshold\$4 with upper	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/05/13 11:37
S31	17366	threshold\$4 with upper with lower	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/05/13 11:38

S32	242	threshold\$4 with upper with lower same defect	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/05/13 11:38
S33	130	threshold\$4 with upper with lower same defect and (pixel or image or (picture adj element))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/05/13 11:41
S34	75	threshold\$4 with upper with lower same defect and (pixel or image or (picture adj element)) with (difference or subtract\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/05/13 11:58
S35	290	382/172.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/05/13 12:02
S36	15	382/172.ccls. and upper near2 threshold\$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/05/13 12:03
S37	1517	threshold with (region or area or zone) with defect	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 13:40
S38	510	threshold with (region or area or zone) with defect and wafer	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 13:40

S39	166	threshold near3 (region or area or zone) with defect and wafer	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 13:41
S40	65	threshold near3 (region or area or zone) with defect with (within or between or inside or in) and wafer	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 13:55
S41	166	threshold near3 (region or area or zone) with defect and wafer	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 14:11
S42	319	thermocoupl\$4 with camera	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 14:38
S43	42	thermocoupl\$4 with camera and wafer	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 14:39
S44	32	thermocoupl\$4 with camera and wafer and difference	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 14:49
S45	978	382/145.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 15:13
S46	451	382/145.ccls. and threshold\$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 15:13

S47	227	382/145.ccls. and threshold\$4 with (window or box or area or zone or region or range or limit)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 15:13
S48	227	382/145.ccls. and threshold\$4 with (window or box or area or zone or region or range or limit)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 15:14
S49	150	382/145.ccls. and threshold\$4 near4 (window or box or area or zone or region or range or limit)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 15:14
S50	68	382/145.ccls. and threshold\$4 near4 (window or box or area or zone or region or range or limit) same defect	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/08/15 15:25

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